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MCP1401/02

Tiny 500 mA, High-Speed Power MOSFET Driver

Features

- · High Peak Output Current: 500 mA (typical)
- · Wide Input Supply Voltage Operating Range:
 - 4.5V to 18V
- Low Shoot-Through/Cross-Conduction Current in Output Stage
- · High Capacitive Load Drive Capability:
 - 470 pF in 19 ns (typical)
 - 1000 pF in 34 ns (typical)
- · Short Delay Times: 35 ns (typical)
- · Matched Rise/Fall Times
- · Low Supply Current:
 - With Logic '1' Input 0.85 mA (typical)
 - With Logic '0' Input 0.1 mA (typical)
- Latch-Up Protected: Will Withstand 500 mA Reverse Current
- · Logic Input Will Withstand Negative Swing Up To 5V
- Space-saving 5-Lead SOT-23 Package

Applications

- · Switch Mode Power Supplies
- · Pulse Transformer Drive
- · Line Drivers
- · Motor and Solenoid Drive

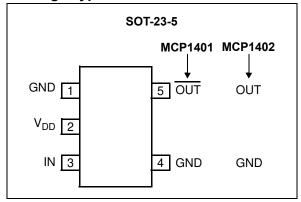
General Description

The MCP1401/02 are high speed MOSFET drivers capable of providing 500 mA of peak current. The inverting or non-inverting single channel output is directly controlled from either TTL or CMOS (3V to 18V). These devices also feature low shoot-through current, matched rise/fall times and propagation delays which make them ideal for high switching frequency applications.

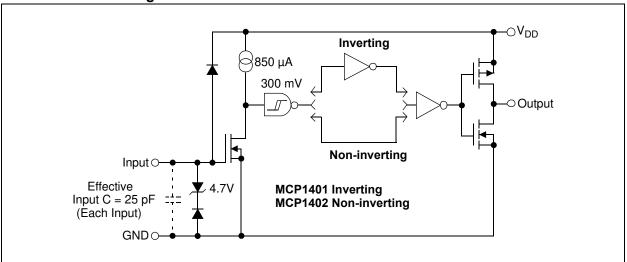
The MCP1401/02 devices operate from a 4.5V to 18V single power supply and can easily charge and discharge 470 pF gate capacitance in under 19 ns (typical). They provide low enough impedances in both the on and off states to ensure the MOSFETs intended state will not be affected, even by large transients.

These devices are highly latch-up resistant under any conditions within their power and voltage ratings. They are not subject to damage when up to 5V of noise spiking (of either polarity) occurs on the ground pin. They can accept, without damage or logic upset, up to 500 mA of reverse current being forced back into their outputs. All terminals are fully protect against Electrostatic Discharge (ESD) up to 3 kV (HBM) and 400V (MM).

Package Types



Functional Block Diagram



1.0 ELECTRICAL CHARACTERISTICS

Absolute Maximum Ratings †

Supply Voltage	+20V
Input Voltage	$(V_{DD} + 0.3V)$ to $(GND - 5V)$
Input Current (V _{IN} >V _{DD})	50 mA
Package Power Dissipation (T _A =	= 50°C)
SOT-23-5	0.39W

† **Notice:** Stresses above those listed under "Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at those or any other conditions above those indicated in the operational sections of this specification is not intended. Exposure to maximum rating conditions for extended periods may affect device reliability.

DC CHARACTERISTICS (NOTE 2)

Electrical Specifications: Unless otherwise indicated, $T_A = +25^{\circ}C$, with 4.5V $\leq V_{DD} \leq 18V$.										
Parameters	Sym	Min	Тур	Max	Units	Conditions				
Input										
Logic '1', High Input Voltage	V _{IH}	2.4	1.5	_	V					
Logic '0', Low Input Voltage	V_{IL}	_	1.3	0.8	V					
Input Current	I _{IN}	-1	_	1	μΑ	$0V \le V_{IN} \le V_{DD}$				
Input Voltage	V_{IN}	-5	_	V _{DD} +0.3	V					
Output										
High Output Voltage	V _{OH}	$V_{DD} - 0.025$	_	_	V	DC Test				
Low Output Voltage	V _{OL}	_	_	0.025	V	DC Test				
Output Resistance, High	R _{OH}	_	12	18	Ω	I _{OUT} = 10 mA, V _{DD} = 18V				
Output Resistance, Low	R _{OL}	_	10	16	Ω	$I_{OUT} = 10 \text{ mA}, V_{DD} = 18V$				
Peak Output Current	I _{PK}	_	0.5	_	Α	V _{DD} = 18V (Note 2)				
Latch-Up Protection With- stand Reverse Current	I _{REV}	_	>0.5	_	Α	Duty cycle \leq 2%, t \leq 300 μ s				
Switching Time (Note 1)										
Rise Time	t _R	_	19	25	ns	Figure 4-1, Figure 4-2 C _L = 470 pF				
Fall Time	t _F	_	15	20	ns	Figure 4-1, Figure 4-2 C _L = 470 pF				
Delay Time	t _{D1}	_	35	40	ns	Figure 4-1, Figure 4-2				
Delay Time	t _{D2}	_	35	40	ns	Figure 4-1, Figure 4-2				
Power Supply	•	•		•		•				
Supply Voltage	V_{DD}	4.5	_	18.0	V					
Power Supply Current	I _S	_	0.85	1.1	mA	$V_{IN} = 3V$				
	I _S	_	0.10	0.20	mA	$V_{IN} = 0V$				

Note 1: Switching times ensured by design.

2: Tested during characterization, not production tested.

DC CHARACTERISTICS (OVER OPERATING TEMPERATURE RANGE)

Electrical Specifications: Unless otherwise indicated, operating temperature range with $4.5V \le V_{DD} \le 18V$.										
Parameters	Sym	Min	Тур	Max	Units	Conditions				
Input										
Logic '1', High Input Voltage	V _{IH}	2.4	_	_	V					
Logic '0', Low Input Voltage	V _{IL}	_	_	0.8	V					
Input Current	I _{IN}	-10	_	+10	μΑ	$0V \le V_{IN} \le V_{DD}$				
Input Voltage	V _{IN}	-5	_	V _{DD} +0.3	V					
Output										
High Output Voltage	V _{OH}	V _{DD} – 0.025	_	_	V	DC TEST				
Low Output Voltage	V _{OL}	_	_	0.025	V	DC TEST				
Output Resistance, High	R _{OH}	_	12	18	Ω	I _{OUT} = 10 mA, V _{DD} = 18V				
Output Resistance, Low	R _{OL}	_	10	16	Ω	I _{OUT} = 10 mA, V _{DD} = 18V				
Switching Time (Note 1)										
Rise Time	t _R	_	20	30	ns	Figure 4-1, Figure 4-2 C _L = 470 pF				
Fall Time	t _F	_	18	28	ns	Figure 4-1, Figure 4-2 C _L = 470 pF				
Delay Time	t _{D1}	_	40	51	ns	Figure 4-1, Figure 4-2				
Delay Time	t _{D2}	_	40	51	ns	Figure 4-1, Figure 4-2				
Power Supply										
Supply Voltage	V_{DD}	4.5	_	18.0	V					
Power Supply Current	I _S	_ _	0.90 0.11	1.10 0.20	mA mA	$V_{IN} = 3V$ $V_{IN} = 0V$				

Note 1: Switching times ensured by design.

TEMPERATURE CHARACTERISTICS

Electrical Specifications: Unless otherwise noted, all parameters apply with $4.5V \le V_{DD} \le 18V$.									
Parameters Sym Min Typ Max Units Conditions									
Temperature Ranges									
Specified Temperature Range	T _A	-40	_	+125	°C				
Maximum Junction Temperature	TJ	_	_	+150	°C				
Storage Temperature Range	T _A	-65	_	+150	°C				
Package Thermal Resistances									
Thermal Resistance, 5L-SOT-23	θ_{JA}		256	_	°C/W				

^{2:} Tested during characterization, not production tested.

2.0 TYPICAL PERFORMANCE CURVES

Note: The graphs and tables provided following this note are a statistical summary based on a limited number of samples and are provided for informational purposes only. The performance characteristics listed herein are not tested or guaranteed. In some graphs or tables, the data presented may be outside the specified operating range (e.g., outside specified power supply range) and therefore outside the warranted range.

Note: Unless otherwise indicated, $T_A = +25^{\circ}C$ with $4.5V \le V_{DD} \le 18V$.

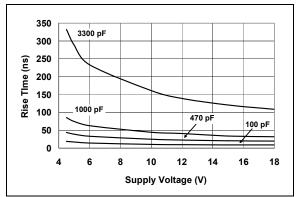


FIGURE 2-1: Rise Time vs. Supply Voltage.

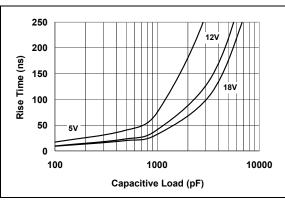


FIGURE 2-2: Rise Time vs. Capacitive Load.

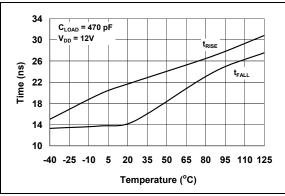


FIGURE 2-3: Rise and Fall Times vs. Temperature.

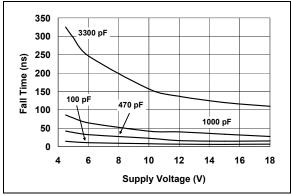


FIGURE 2-4: Fall Time vs. Supply Voltage.

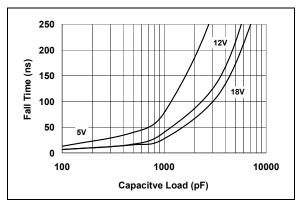


FIGURE 2-5: Fall Time vs. Capacitive Load.

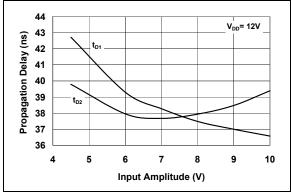


FIGURE 2-6: Propagation Delay vs. Input Amplitude.

Typical Performance Curves (Continued)

Note: Unless otherwise indicated, $T_A = +25^{\circ}C$ with $4.5V \le V_{DD} \le 18V$.

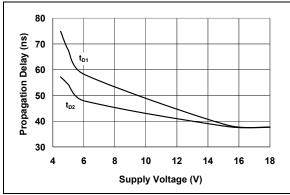


FIGURE 2-7: Propagation Delay Time vs. Supply Voltage.

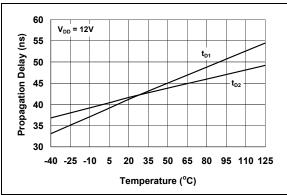


FIGURE 2-8: Propagation Delay Time vs. Temperature.

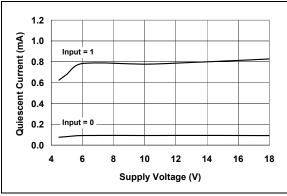


FIGURE 2-9: Quiescent Current vs. Supply Voltage.

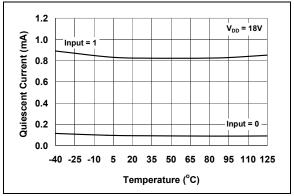


FIGURE 2-10: Quiescent Current vs. Temperature.

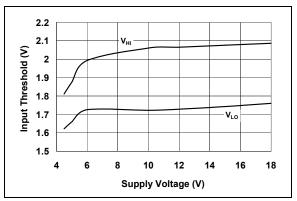


FIGURE 2-11: Input Threshold vs. Supply Voltage.

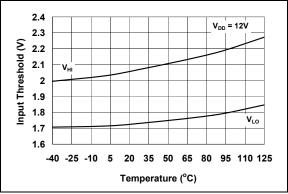


FIGURE 2-12: Input Threshold vs. Temperature.

Typical Performance Curves (Continued)

Note: Unless otherwise indicated, $T_A = +25^{\circ}C$ with $4.5V \le V_{DD} \le 18V$.

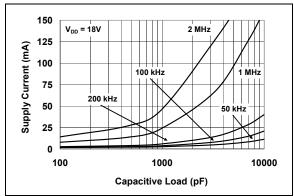


FIGURE 2-13: Capacitive Load.

Supply Current vs.

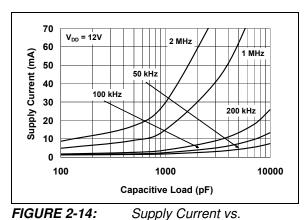


FIGURE 2-14: Capacitive Load.

30 V_{DD} = 6V 2 MHz 1 MHz 200 kHz 15 50 kHz 200 kHz 200 kHz 100 MHz 1000 Capacitive Load (pF)

FIGURE 2-15: Capacitive Load.

Supply Current vs.

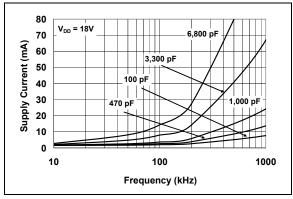


FIGURE 2-16: So Frequency.

RE 2-16: Supply Current vs.

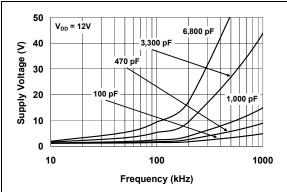


FIGURE 2-17: Frequency.

Supply Current vs.

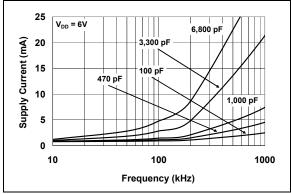


FIGURE 2-18: Frequency.

Supply Current vs.

Typical Performance Curves (Continued)

Note: Unless otherwise indicated, $T_A = +25^{\circ}C$ with $4.5V \le V_{DD} \le 18V$.

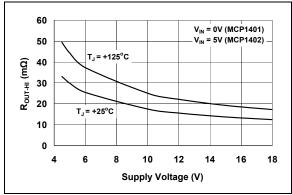


FIGURE 2-19: Output Resistance (Output High) vs. Supply Voltage.

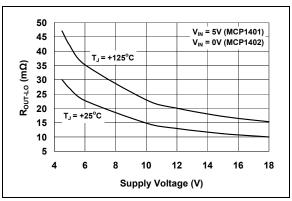


FIGURE 2-20: Output Resistance (Output Low) vs. Supply Voltage.

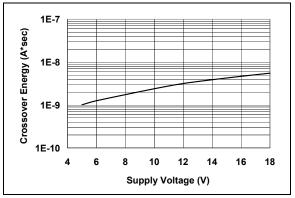


FIGURE 2-21: Crossover Energy vs. Supply Voltage.

3.0 PIN DESCRIPTIONS

The descriptions of the pins are listed in Table 3-1.

TABLE 3-1: PIN FUNCTION TABLE (1)

SOT-23-5	Symbol	Description
1	GND	Ground
2	V_{DD}	Supply Input
3	IN	Control Input
4	GND	Ground
5	OUT	Output

Note 1: Duplicate pins must be connected for proper operation.

3.1 Supply Input (V_{DD})

 V_{DD} is the bias supply input for the MOSFET driver and has a voltage range of 4.5V to 18V. This input must be decoupled to ground with a local capacitor. This bypass capacitor provides a localized low-impedance path for the peak currents that are to be provided to the load.

3.2 Control Input (IN)

The MOSFET driver input is a high-impedance, TTL/CMOS-compatible input. The input also has hysteresis between the high and low input levels, allowing them to be driven from slow rising and falling signals, and to provide noise immunity.

3.3 Ground (GND)

Ground is the device return pin. The ground pin should have a low impedance connection to the bias supply source return. High peak currents will flow out the ground pin when the capacitive load is being discharged.

3.4 Output (OUT)

The output is a CMOS push-pull output that is capable of sourcing and sinking 0.5A of peak current (V_{DD} = 18V). The low output impedance ensures the gate of the external MOSFET will stay in the intended state even during large transients. This output also has a reverse current latch-up rating of 0.5A.

4.0 APPLICATION INFORMATION

4.1 General Information

MOSFET drivers are high-speed, high current devices which are intended to source/sink high peak currents to charge/discharge the gate capacitance of external MOSFETs or IGBTs. In high frequency switching power supplies, the PWM controller may not have the drive capability to directly drive the power MOSFET. A MOSFET driver like the MCP1401/02 family can be used to provide additional source/sink current capability.

4.2 MOSFET Driver Timing

The ability of a MOSFET driver to transition from a fully off state to a fully on state are characterized by the drivers rise time ($t_{\rm R}$), fall time ($t_{\rm F}$), and propagation delays ($t_{\rm D1}$ and $t_{\rm D2}$). The MCP1401/02 family of drivers can typically charge and discharge a 470 pF load capacitance in 19 ns along with a typical matched propagation delay of 35 ns. Figure 4-1 and Figure 4-2 show the test circuit and timing waveform used to verify the MCP1401/02 timing.

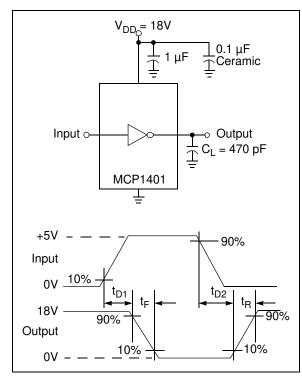


FIGURE 4-1: Inverting Driver Timing Waveform.

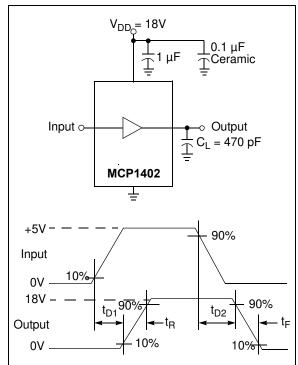


FIGURE 4-2: Non-Inverting Driver Timing Waveform.

4.3 Decoupling Capacitors

Careful layout and decoupling capacitors are highly recommended when using MOSFET drivers. Large currents are required to charge and discharge capacitive loads quickly. For example, approximately 550 mA are needed to charge a 470 pF load with 18V in 15 ns.

To operate the MOSFET driver over a wide frequency range with low supply impedance, a ceramic and low ESR film capacitor is recommended to be placed in parallel between the driver V_{DD} and GND. A 1.0 μF low ESR film capacitor and a 0.1 μF ceramic capacitor placed between pins 2 and 1 should be used. These capacitors should be placed close to the driver to minimized circuit board parasitics and provide a local source for the required current.

4.4 PCB Layout Considerations

Proper PCB layout is important in a high current, fast switching circuit to provide proper device operation and robustness of design. PCB trace loop area and inductance should be minimized by the use of ground planes or trace under MOSFET gate drive signals, separate analog and power grounds, and local driver decoupling.

Placing a ground plane beneath the MCP1401/02 will help as a radiated noise shield as well as providing some heat sinking for power dissipated within the device.

4.5 **Power Dissipation**

The total internal power dissipation in a MOSFET driver is the summation of three separate power dissipation elements.

EQUATION 4-1:

$$P_T = P_L + P_Q + P_{CC}$$

Where:

Total power dissipation Load power dissipation

Quiescent power dissipation

 P_CC Operating power dissipation

4.5.1 CAPACITIVE LOAD DISSIPATION

The power dissipation caused by a capacitive load is a direct function of frequency, total capacitive load, and supply voltage. The power lost in the MOSFET driver for a complete charging and discharging cycle of a MOSFET is shown in Equation 4-2.

EQUATION 4-2:

$$P_L = f \times C_T \times {V_{DD}}^2$$

Where:

f Switching frequency

 C_T Total load capacitance V_{DD}

MOSFET driver supply voltage

4.5.2 QUIESCENT POWER DISSIPATION

The power dissipation associated with the quiescent current draw depends upon the state of the input pin. The MCP1401/02 devices have a quiescent current draw when the input is high of 0.85 mA (typical) and 0.1 mA (typical) when the input is low. The guiescent power dissipation is shown in Equation 4-3.

EQUATION 4-3:

$$P_Q = (I_{QH} \times D + I_{QL} \times (1 - D)) \times V_{DD}$$

Where:

Quiescent current in the high I_{QH}

state

D Duty cycle

 I_{QL} Quiescent current in the low

 V_{DD} MOSFET driver supply voltage

4.5.3 OPERATING POWER DISSIPATION

The operating power dissipation occurs each time the MOSFET driver output transitions because for a very short period of time both MOSFETs in the output stage are on simultaneously. This cross-conduction current leads to a power dissipation described in Equation 4-4.

EQUATION 4-4:

$$P_{CC} = CC \times f \times V_{DD}$$

Where:

CC Cross-conduction constant

(A*sec)

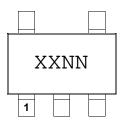
Switching frequency f

MOSFET driver supply voltage V_{DD}

5.0 PACKAGING INFORMATION

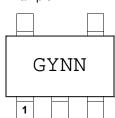
5.1 Package Marking Information (Not to Scale)

5-Lead SOT-23



Standard Markings for SOT-23						
Part Number Code						
MCP1401T-E/OT	GYNN					
MCP1402T-E/OT	GZNN					





Legend: XX...X Customer-specific information

Y Year code (last digit of calendar year)
YY Year code (last 2 digits of calendar year)
WW Week code (week of January 1 is week '01')

NNN Alphanumeric traceability code

(e3) Pb-free JEDEC designator for Matte Tin (Sn)

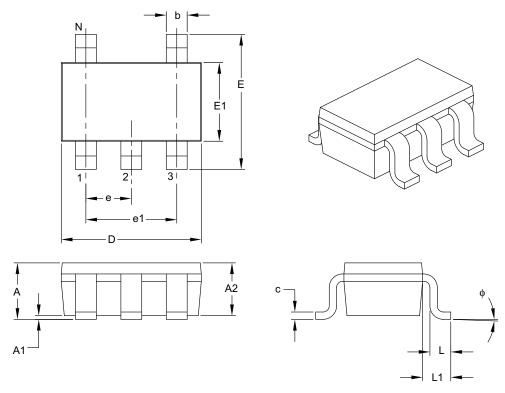
This package is Pb-free. The Pb-free JEDEC designator (e3

can be found on the outer packaging for this package.

Note: In the event the full Microchip part number cannot be marked on one line, it will be carried over to the next line, thus limiting the number of available characters for customer-specific information.

5-Lead Plastic Small Outline Transistor (OT) [SOT-23]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



	Units	MILLIMETERS					
	Dimension Limits	MIN	NOM	MAX			
Number of Pins	N		5				
Lead Pitch	е		0.95 BSC				
Outside Lead Pitch	e1		1.90 BSC				
Overall Height	A	0.90 – 1.45					
Molded Package Thickness	A2	0.89 – 1.30					
Standoff	A1	0.00	_	0.15			
Overall Width	E	2.20 – 3.2					
Molded Package Width	E1	1.30 – 1.80					
Overall Length	D	2.70	_	3.10			
Foot Length	L	0.10	_	0.60			
Footprint	L1	0.35	_	0.80			
Foot Angle	ф	0°	_	30°			
Lead Thickness	С	0.08 – 0.26					
Lead Width	b	0.20 – 0.51					

Notes:

- 1. Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed 0.127 mm per side.
- 2. Dimensioning and tolerancing per ASME Y14.5M.

BSC: Basic Dimension. Theoretically exact value shown without tolerances.

Microchip Technology Drawing C04-091B

MCP1401/02

NOTES:

APPENDIX A: REVISION HISTORY

Revision B (December 2007)

- Updated the low supply current values.
- Updated Section 5.1 "Package Marking Information (Not to Scale)".

Revision A (June 2007)

· Original Release of this Document.

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NOTES:

PRODUCT IDENTIFICATION SYSTEM

To order or obtain information, e.g., on pricing or delivery, refer to the factory or the listed sales office.

PART NO. X X XX

Device Tape & Reel Temperature Package Range Range

Device: MCP1401: 500 mA MOSFET Driver, Inverting

MCP1402: 500 mA MOSFET Driver, Non-Inverting

Tape and Reel T = Tape and Reel

Temperature Range: $E = -40^{\circ}C \text{ to } +125^{\circ}C$

Package: * OT = Plastic Thin Small Outline Transistor (OT), 5-Lead

* All package offerings are Pb Free (Lead Free)

Examples:

a) MCP1401T-E/OT: 500 mA Inverting

MOSFET Driver, 5LD SOT-23 package.

a) MCP1402T-E/OT 500 mA Non-Inverting,

MOSFET Driver,

5LD SOT-23 package,

MCP1401/02

NOTES:

Note the following details of the code protection feature on Microchip devices:

- · Microchip products meet the specification contained in their particular Microchip Data Sheet.
- Microchip believes that its family of products is one of the most secure families of its kind on the market today, when used in the intended manner and under normal conditions.
- There are dishonest and possibly illegal methods used to breach the code protection feature. All of these methods, to our
 knowledge, require using the Microchip products in a manner outside the operating specifications contained in Microchip's Data
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